

Search Notes

Application/Control No.

10/529,305

Examiner

Mohamed Charioui

Applicant(s)/Patent under
Reexamination

GUEVREMONT ET AL.

Art Unit

2857

SEARCHED

Class	Subclass	Date	Examiner
702	57, 64-67, 70-73, 75, 77	8/3/2006	MC
702	85, 106	8/3/2006	MC
702	189, 190	8/3/2006	MC
702	193, 194	8/3/2006	MC
250	282, 286	8/3/2006	MC
250	292	8/3/2006	MC
356	437	8/3/2006	MC
379	24	8/3/2006	MC
331	2, 14	8/3/2006	MC
327	94	8/3/2006	MC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: sampl\$6 and optimi\$6 and (amplitude or magnitude) and (faims or "IMS") and spectromet\$3 and ((correct\$6 or adjust\$6	8/3/2006	MC
or calibrat\$6) near5 phase or amplitude)	8/3/2006	MC
East: (sampl\$6 near5 (waveform\$1 or sinusoid\$4 or function\$1 or waves)) and optimi\$6 and (amplitude or magnitude)	8/3/2006	MC
and (faims or "IMS") and spectromet\$3	8/3/2006	MC
East: ((correct\$6 or adjust\$6 or calibrat\$6) near5 phase or amplitude) and sinusoi\$6 and "pi/2" and asymmetric and fourier	8/3/2006	MC
East: ((correct\$6 or adjust\$6 or calibrat\$6) near5 phase or amplitude) and sinusoi\$6 and "pi/2" and asymmetric	8/3/2006	MC